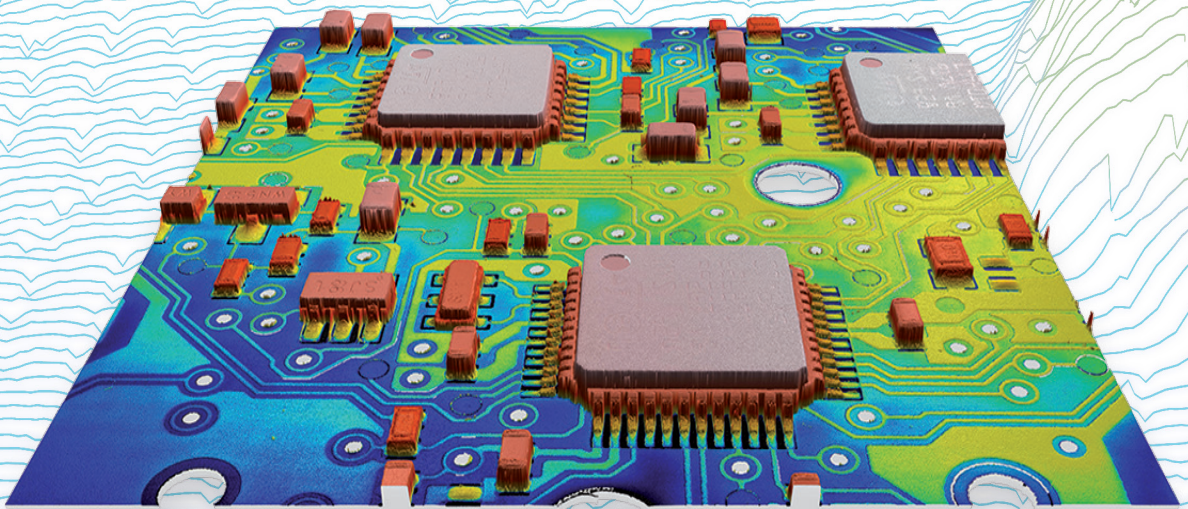
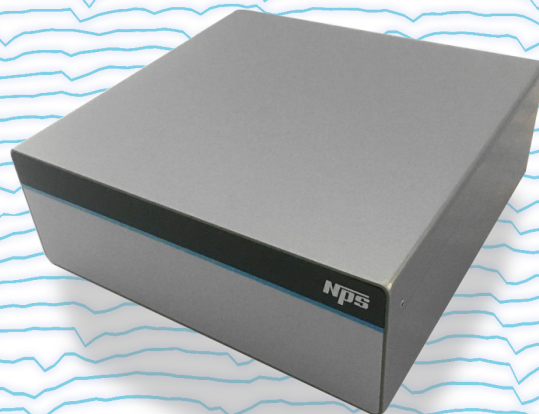
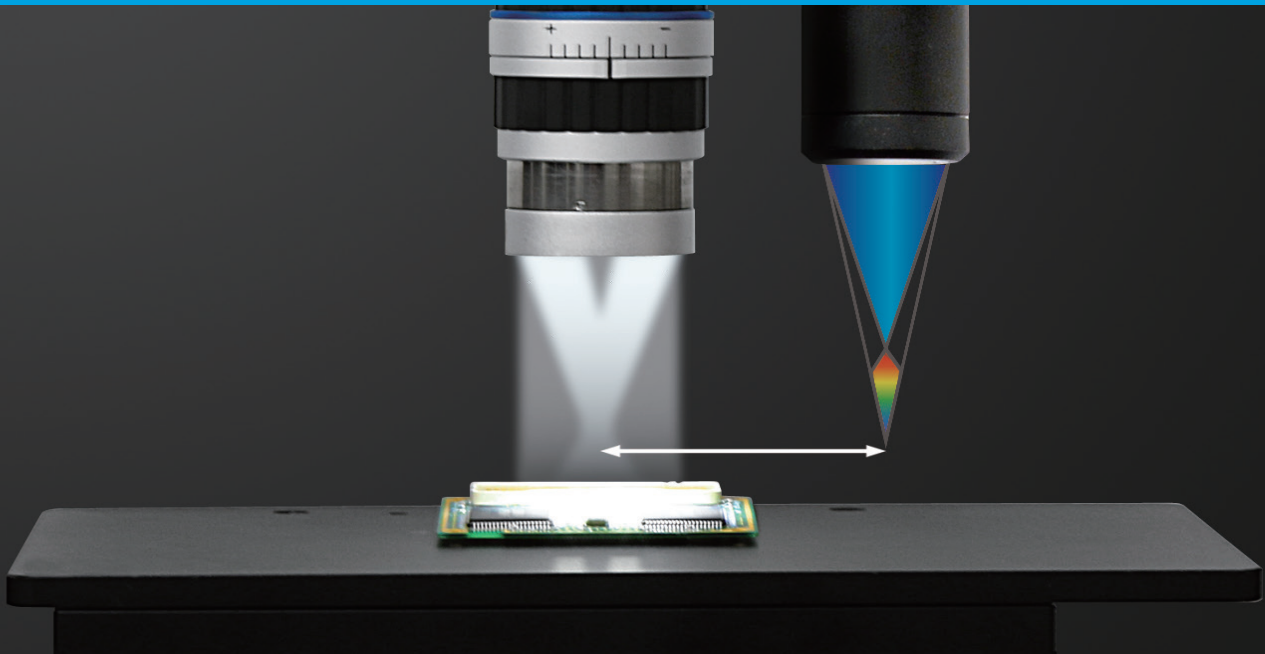


NPS



Metrology meets Microscopy
Nano Point Scanner | 3D Profilometry





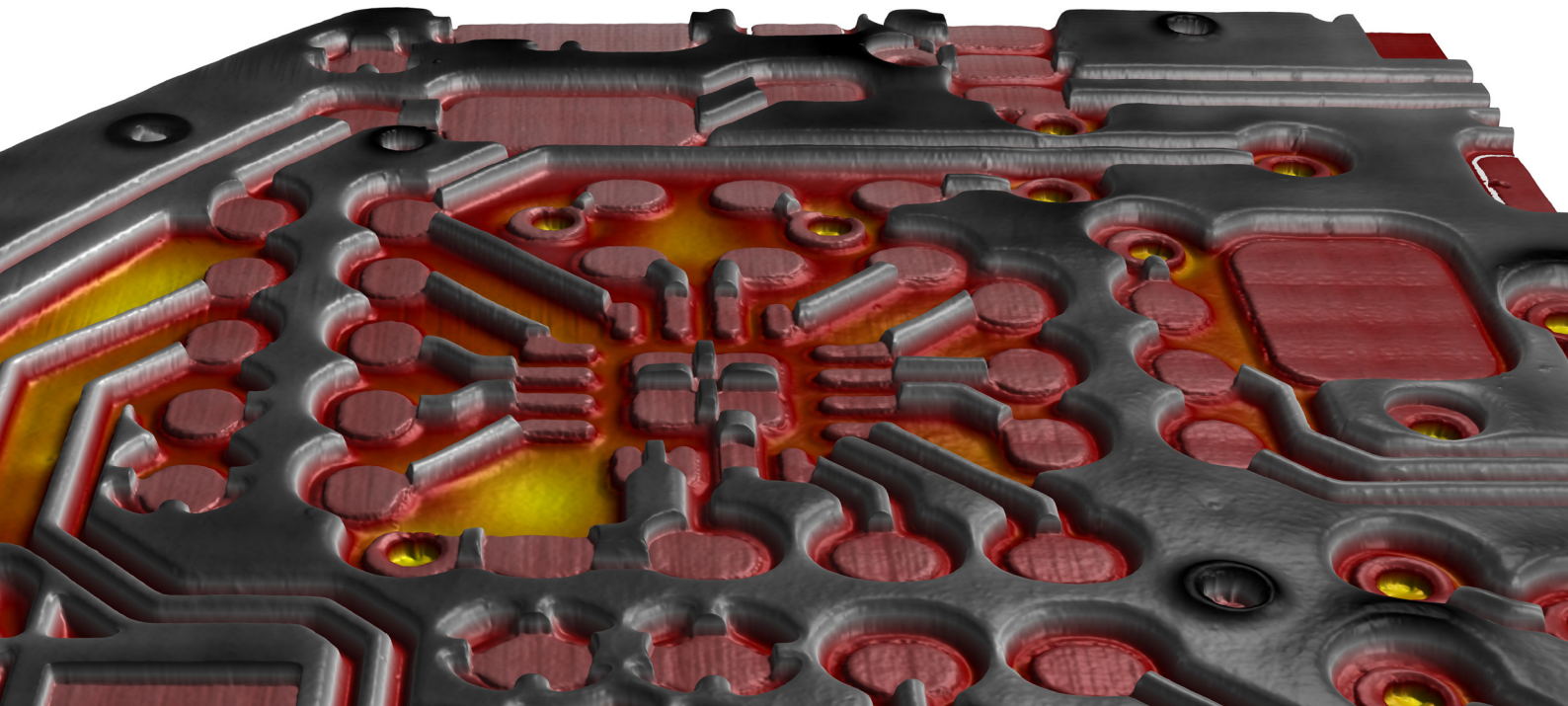
Nano Point Scanner + Hirox RH-2000:

NPS White Light Confocal Profilometry

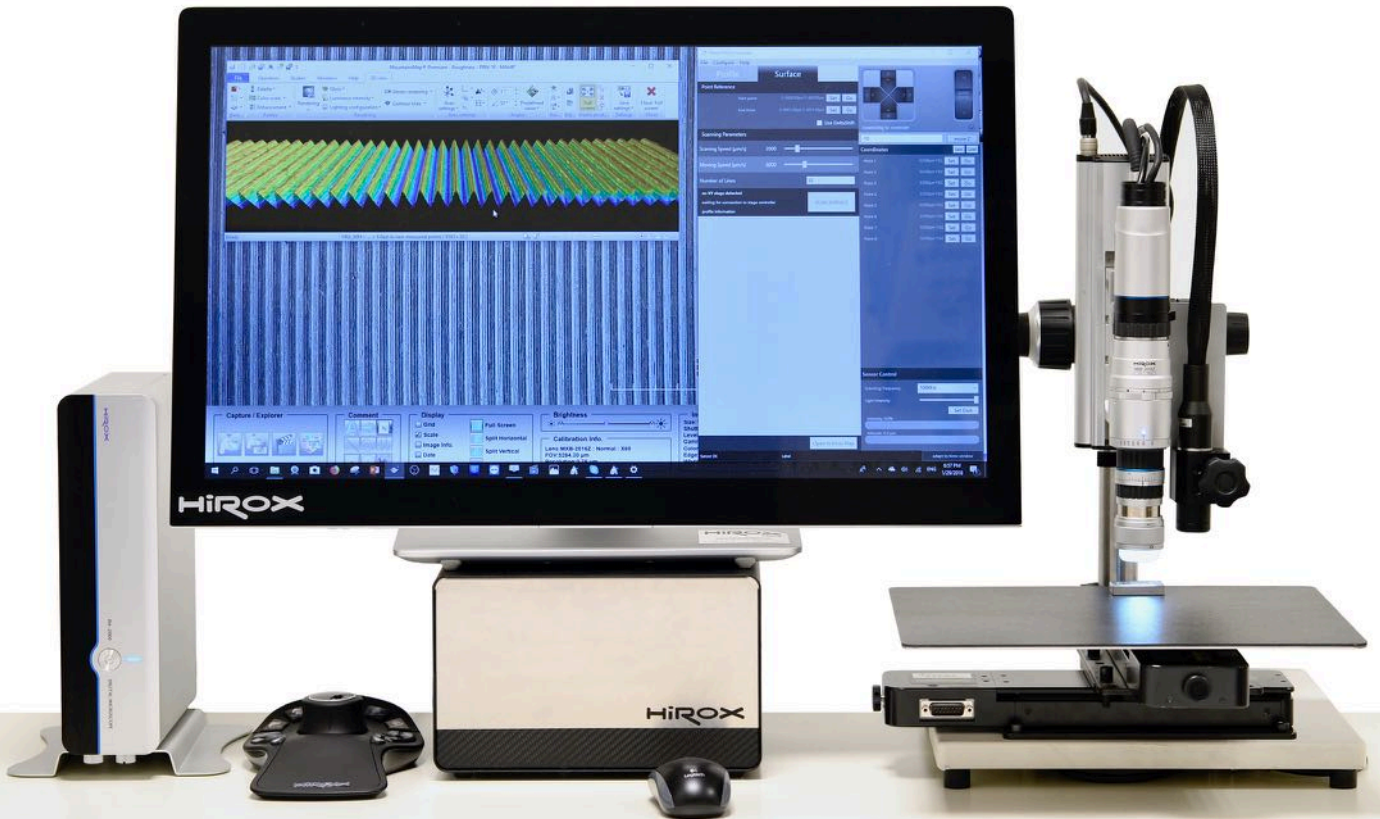
- Submicron Z Precision
- Ultra Fast Profiling
- ISO Certified Measurement
- Automatization & Reports

HIROX 3D Digital Microscopy

- High Resolution Image Quality
- Ultra Fast 3D Stacking
- Multiple Lighting Possibilities
- Full Flexibility: Sample & Stand

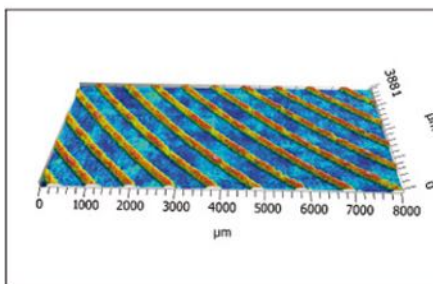


NPS & Hirox: metrology meets microscopy



HiROX EUROPE

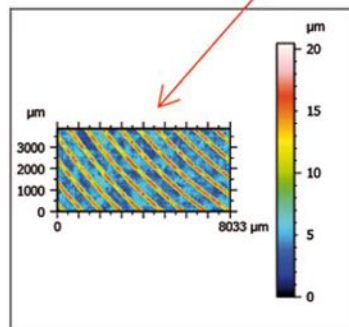
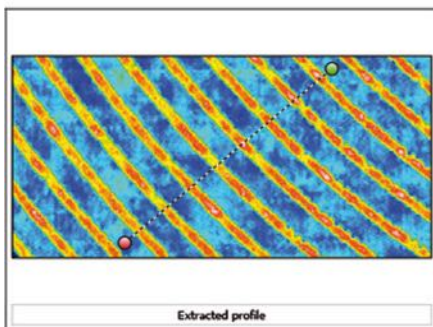
3DView NPS



HIROX High Resolution stitching:



Height Information



Extracted area: fast 3D scan

Identity card	
Duration of the measurement:	23 m 49 s
Axis:	X
Length:	8033 μm
Size:	919 points
Spacing:	8.75 μm
Axis:	Y
Length:	3881 μm
Size:	226 lines
Spacing:	17.2 μm
Axis:	Z
Max:	13.0 μm

Introducing the Nano Point Scanner

Confocal White Light Profilometry

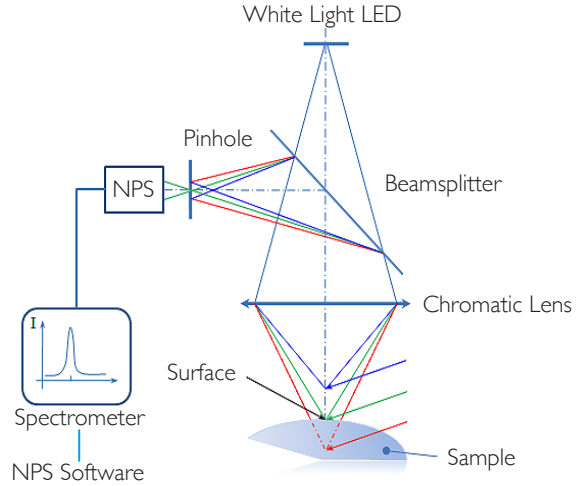
The NPS Technology

The NPS is an innovative non-contact confocal 3D profilometer measuring altitude in real time, for profile or surface scanning:

1. The white light LED beam is projected through a beamsplitter and a chromatic lens to the surface of the sample
2. The reflected light beam from the sample is filtered in a confocal pinhole, isolating one single wavelength in perfect focus
3. The NPS spectrometer is accurately translating this wavelength into height information and display it visually in the NPS software
4. Up to 2000 height information per second are acquired in real time creating a profile when moving the XY stage

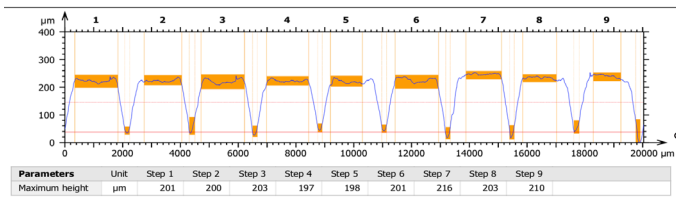
You can select between two modes: **Profile** or **Surface**

NPS Confocal White Light Sensor



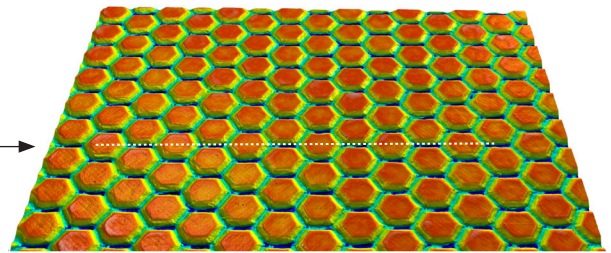
High Speed Profile (1 axis scan)

By moving the sample with the high precision motorized XY stage in one axis, the NPS acquires a series of focused points at a chosen interval, creating a fast profile: the measurement of height, distance, radius, line roughness (Ra, Rz, Rt,...) and much more can be done within seconds!



High Resolution Surface (2 axis scan)

By creating a series of aligned profiles, the NPS acquires XYZ information creating a high resolution 3D surface: volume, surface roughness (Sa, Sz,...), complex shape, 3D waviness and much more can be measured – the duration of the scan is adjusted by the amount of lines, scanning speed and the dimension of the sample!



Works On Any Type Of Surface



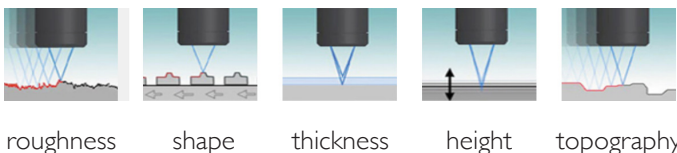
The confocal system generates a sharply focused observation plane. Points located above or below the object surface are completely out of focus, so that the type of material does not matter: the sample can be mirror, shiny, reflective or rough, it can be opaque or completely transparent

Quality and Standards Compliance - ISO



White light chromatic confocal technology is ISO certified for roughness measurement and is currently used by many companies and research centers all over the world. The NPS allows high precision XYZ axis measurement beyond the limitation of optical depth of field.

Wide Range of Measurements



Unlimited Applications

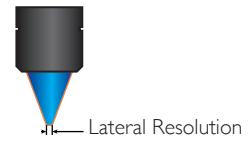
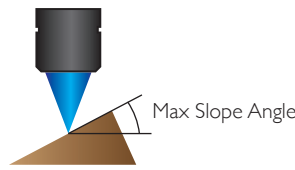
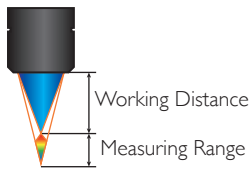
- | | | |
|--------------|-------------------|-------------------|
| Aerospace | Semiconductor | Archeology |
| Automotive | Micro Electronics | Art Restoration |
| Optical Lens | Mobile Phone | Security Printing |
| Watch Makers | Displays | Razor Blades |

The NPS Sensors

The right sensors for your requirements

The NPS System provides a wide range of sensors to achieve seamless highly accurate measurement. Depending on your application, you can select the best sensors for your needs: small measuring range for highest accuracy and roughness measurement or large measuring range for tall sample and form measurements.

NPS Sensors Specifications



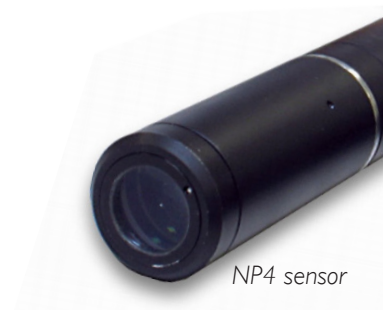
NPS SENSOR					
	NP1	NP2	NP3	NP4	NPX ₃
Measuring Range	150 µm	400 µm	1400 µm	4000 µm	1000 µm
Working distance	3.3 mm	10.8 mm	12 mm	16,2 mm	18,5 mm
Max Sample Slope ¹	42.5°	28°	25°	21°	44°
Lateral Resolution	1 µm	1.8 µm	2.6 µm	4.6 µm	4 µm
Height Accuracy ²	20 nm	45 nm	150 nm	300 nm	100 nm
Suitable for Roughness	OK	OK	OK		OK

¹Max Sample Slope on perfect mirror surface
²Min Z measurement depends on XY stage
³NPX is not compatible with delta shift on the 100x100 mm stage

NPS Advantages



NPX sensor



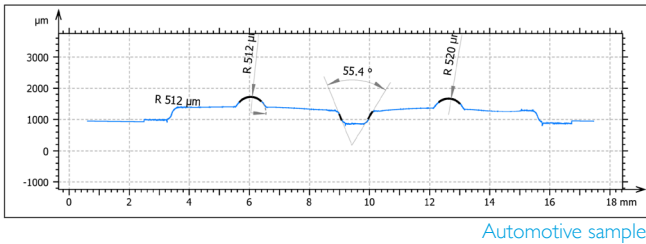
NP4 sensor

RELIABLE	UNIVERSAL	POWERFUL
ISO CERTIFIED	NON CONTACT	FAST PROFILE
HIGH REPEATABILITY	WORKS IN AMBIANT LIGHT	NO STITCHING
HIGH RESOLUTION	MIRROR & TRANSPARENT	LARGE AREA 3D

Multiple measurement possibilities

By combining high precision measurements with advanced metrology software, the NPS will match all your metrology requirements

PROFILE & MULTI PROFILE

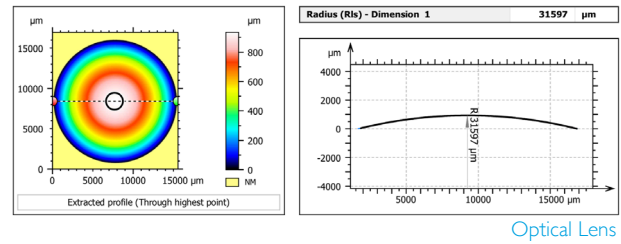


The fastest way to execute a measurement! After scanning between two points, the NPS will display the profile: you can then adjust the level, measure horizontal & vertical distances as well as Ra, Rz and Rt measurements.

For advanced measurement, select the desired Hirox Map template inside the NPS menu.

With the new programmable multi profile function, simply execute several individual profiles combined in one single report.

SHAPE & FORMS



Surface shape and geometry can be easily measured: on a spherical object, the measurement results of a curvature can be compared to manufacturing specification for example.

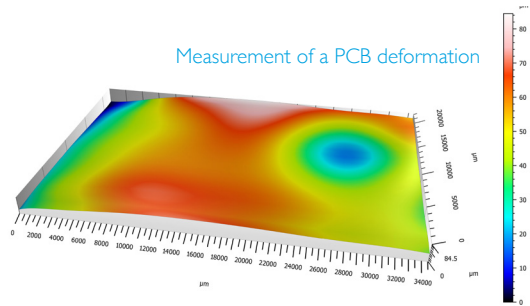
Other shapes such as lines, planes, spheres, cylinders or free-form are typical objects that the NPS can measure: length, height, radius, angle, volume and much more.

With large measuring ranges up to 4000 micrometer, various shape and forms can be captured and measured.

FLATNESS, WAVINESS & COPLANARITY

Warp, Deformation, Waviness, or Flatness are easily measured on large areas with the Nano Point Scanner! Thanks to XY stage up to 500x500mm, it's possible to measure defects that can occur from machine or work anomaly, residual stress, vibrations, or heat treatment for example.

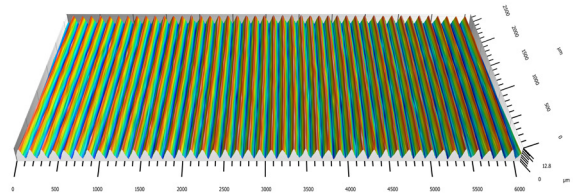
Coplanarity is another parameter that required long distances and high level of Z accuracy. This can be done either thanks to a profile or a surface.



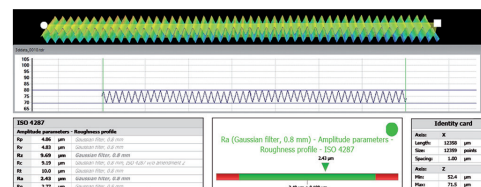
ROUGHNESS, TEXTURE & DEFECTS

Surface metrology determines surface topography, which is essential for confirming a surface's suitability for its function. Surface measurement includes profile roughness (Ra), surface roughness (Sa), surface texture, asperity and structural characterization.

For manufacturing and design purposes, measurement is critical to ensure that the finished material meets the design specification.



- ▶ Distances
- ▶ Volume
- ▶ Roughness
- ▶ Waviness
- ▶ Roundness
- ▶ Topography
- ▶ Flatness
- ▶ Coplanarity
- ▶ Deformation
- ▶ Tribology



NPS Interface: fast and easy

A dedicated software to get quickly and easily the best out of white light confocal technology!

Profile or Surface?

Simply use the high resolution optics from the RH-2000 to do the selection of the points of interest (deltashift function) and let the NPS do the rest: profile, multi profile or surface are just a few clicks away

Fast Scan!

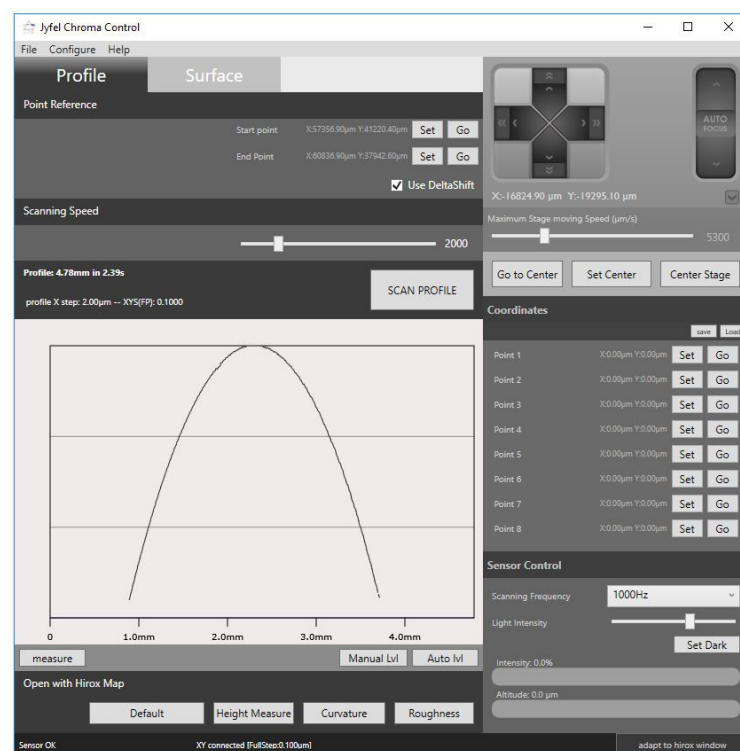
Select the scanning speed, X and Y steps are displayed, as well as the total scanning area: start the scan!

Live Display

View the profile or false colour scan displayed in real time during the scan.

Level & Measure

For fast tests and measurements, use the built-in auto function to adjust the level, then measure height and distances directly within the NPS interface.



XYZ & Auto Focus

Speed control: fine tune the Hirox XY motorised movement!
Auto Focus: bring your sensor to the center of the measuring range with just one-click!

Point of Interest

Set, Go and Save: multiple points of interest can be easily used for Profile, multi-Profile or Surface scans!

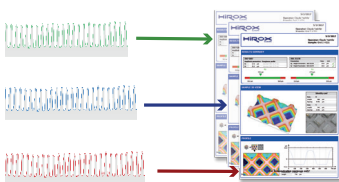
Sensor Control

Adjust Frequency and Light intensity according to the reflectivity of your sample and the acquisition speed you wish

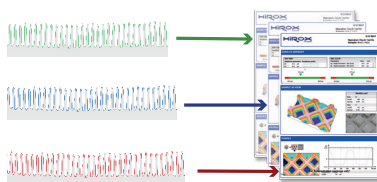
Easy Measure and Report with Hirox Maps

You can customize up to 4 Templates for profile or surface. Apply them to your sample automatically in one click

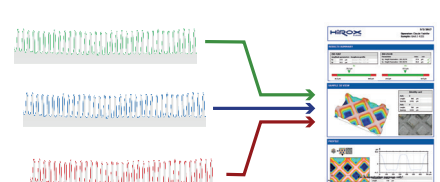
Create your first inspection report and use it as template for similar samples



Scan all your samples and it will generate a report for each sample



Get statistics, averages and Fail / Pass of all your samples in one single excel file



Hirox Maps - Advanced Metrology software

By combining High precision measurement with Advanced metrology software, the NPS will match all your metrology requirements

Hirox Maps Mountains Technology!

The Mountains technology is the most advanced metrology solution on the market:

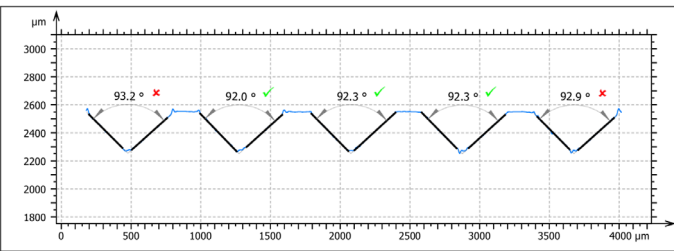
- Real time imaging of 3D surface topography
- 3D surface overlays for fast feature location: height color + intensity images from the NPS combined
- Remove data acquisition and sample artifacts
- Extraction of area, Level correction, Shape Correction
- Full measurement suite on profiles and 3D data with user and process tracability

Powerful & Simple

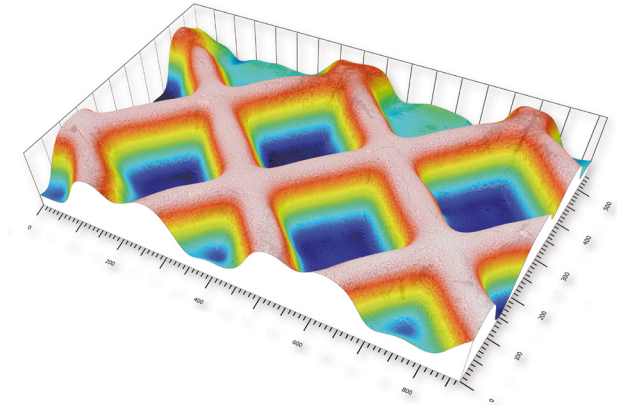
While many functions involve complex calculations, every effort is made to ensure that accessing and using these functions is as easy as possible.

Also, once a measurement report has been done, all the parameters used can be easily applied to a new sample with tolerance limits showing in green / red.

Every report can then become a measurement template for fast and easy workflow with fail / pass!



automatic display of tolerance: angle measurements on a thread



ISO & National Metrology Standards

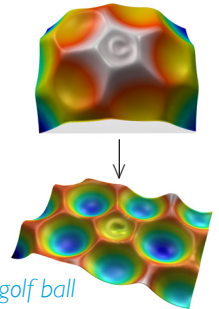
Mountains Map has an installed base of 10,000+ licenses worldwide, supports ISO and national metrology standards.

Mountains Map works in over 10 languages!



Form Removal & Non Measured Points

The NPS software always exports unprocessed raw data, which can then be filtered in Hirox Maps. You can for example display or fill the non measured points, but also remove the form to keep only the surface



Form removal of a golf ball

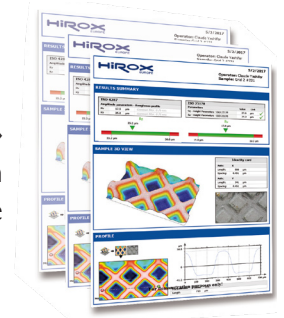
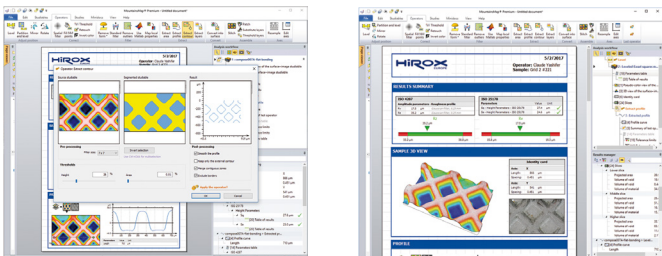
Easy Reporting

- Easy integration into lab and production environments - export of all numerical results.
- Easy publication - export analysis documents, pages and individual images up to 1200 dpi.

Analysis Automation

Powerful automation tools ensure high productivity: series of surface data sets can be analyzed automatically and common sequences of analysis step can be saved for insertion any future analysis document.

Pass/fail criteria can be specified for any parameter and green (pass) / red (fail) «traffic lights» are displayed automatically on the report. All the results can be extracted as CSV / Excel format.



Hybrid Digital Microscopy: NPS & RH-2000

Optical 3D surface metrology for industry and research

The perfect combination between optical excellence and non contact metrology:
HIROX RH-2000 3D digital microscope with the NPS - universal solution for your application!

Hirox Optics - High Resolution

Highest optical power
from 0,1x up to 10.000x

Multiple lighting technologies
BF / DF / POL / DIFF / UV,...

Patented HIROX rotary head
360° motorized inspection

NPS Sensors - High Precision

Wide measuring range
from 100µm up to 24.000µm

Big working distance
from 3mm up to 25mm

Various type of measurement
form, flatness, roughness,...

Z axis - Ultra Fine Steps

Motorised Z axis
30 mm with 50 nm steps

Additional manual Z
80 mm manual Z axis

Special design
compact or bridge system

XY axis - High Accuracy

Wide range of movement
from 40x40 mm to 500x500 mm

Special high precision stage
110x75mm movement

Small XY steps
from 0.1 µm



Delta Shift Function

Hirox 3D mouse:
- easy XYZ movement
- set start / end / scan



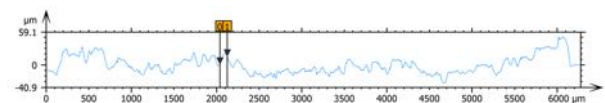
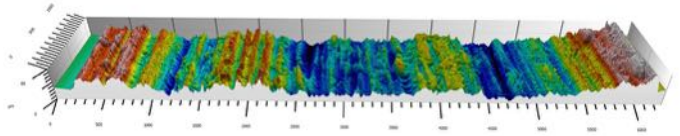
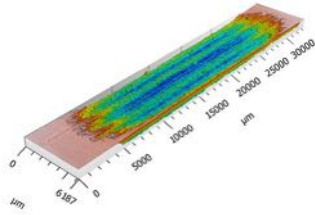
example of stand
500x500mm XY stage
with bridge structure



High Precision 3D scans

Research & Development, Process & Production Control, Laboratory and more!

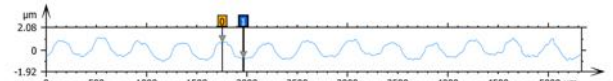
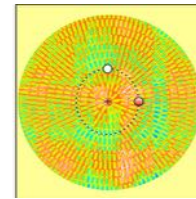
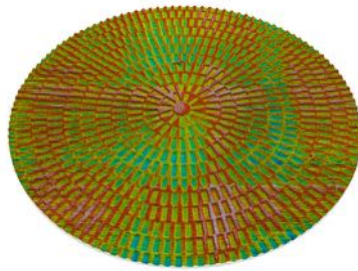
Tribology



Parameters	0-1	Unit
Height difference	14.5	μm

The NPS system revealed complex scratch patterns on a scratch test tribology sample.

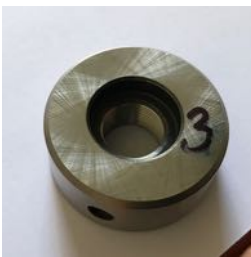
Fresnel Lens



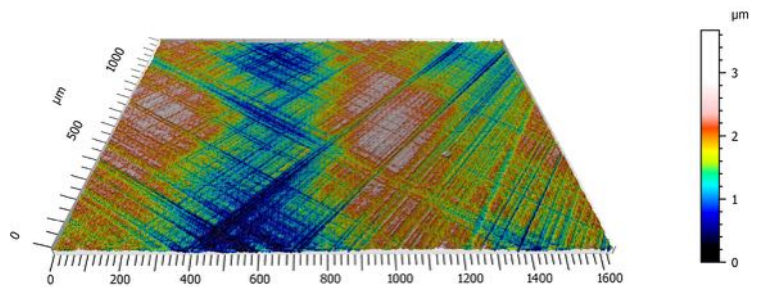
Parameters	0-1	Unit
Height difference	-1.45	μm

Pattern measurement on a complex lens structure

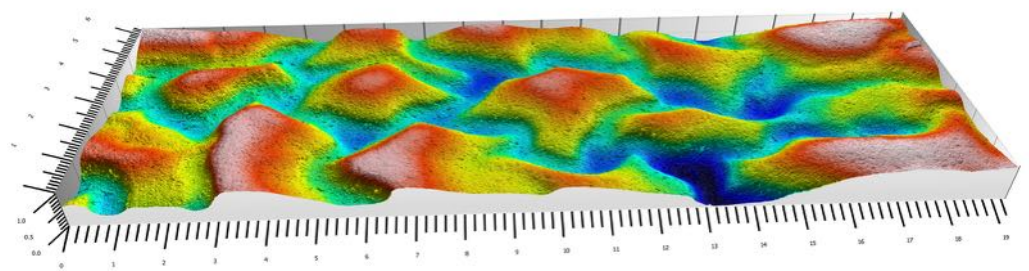
Scratch Tests



Measurement of submicron scratches on a metal surface

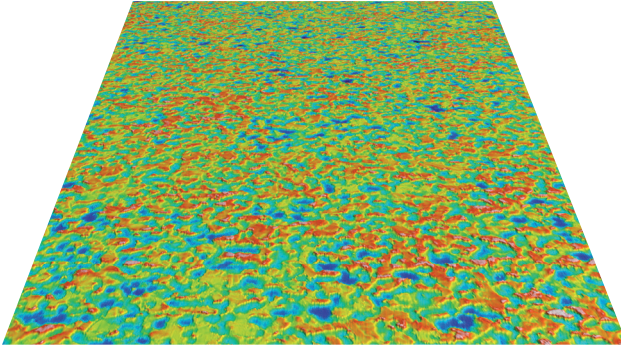


Atacama Stone

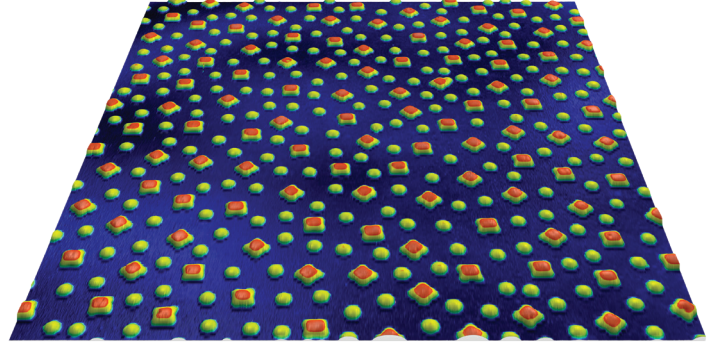


The Atacama stone is a rare artefact due to its complex surface structure. The NPS high accuracy measurement helped the Museum of Natural History in Madrid to visualise better the surface.

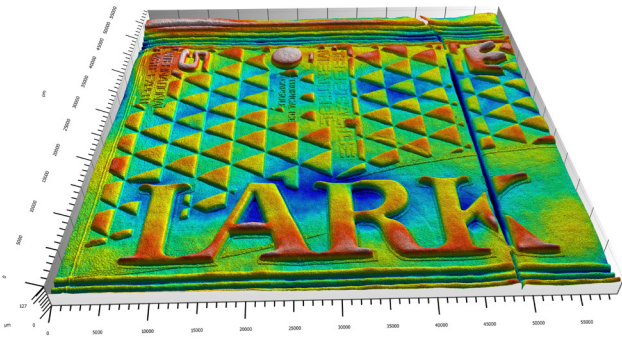
High Precision 3D scans



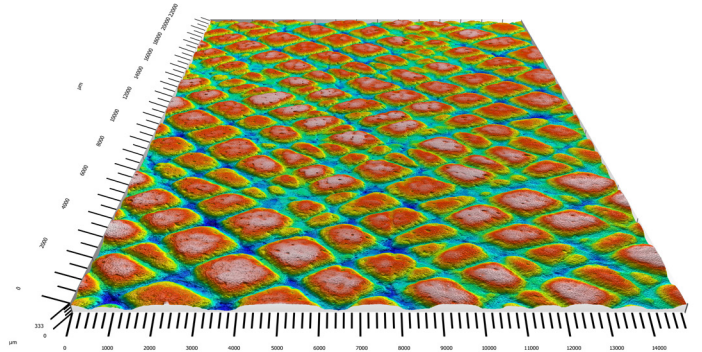
Steel surface



Basketball surface



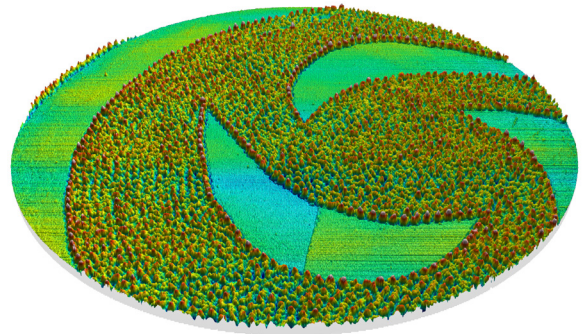
3D packaging



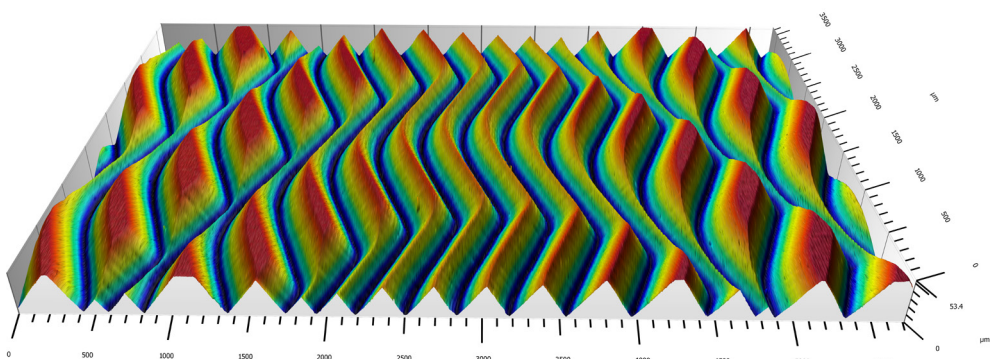
Leather surface



Bullet casing



Shaving Head



Part of a mechanical watch

System Configuration

Choose the NPS sensor that fits your application!
 Choose the Hirox lens that fits your application!
 Choose the stand that fits your application!



MOTORIZED XY STAGE					
	110 X 75	100 X 100	200 X 100	500 x 500	other dimension
Dimensions	110mm x 75mm	100mm x 100mm	200mm x 100mm	500mm x 500 mm	on request
Step per pulse	0.05µm	0.1µm	0.1µm	0.2 µm	on request
Position Accuracy	1µm	1µm	1µm	4µm	on request
Speed	5mm/s	10mm/s	10mm/s	10mm/s	on request
Max Z Vibration Noise	100 nm	200 nm	200 nm	500 nm	on request
Suitable for Roughness	OK	OK	OK		on request

NPS SENSOR					
	NP1	NP2	NP3	NP4	NPX ₃
Measuring Range	150 µm	400 µm	1400 µm	4000 µm	1000 µm
Working distance	3.3 mm	10.8 mm	12 mm	16,2 mm	18,5 mm
Max Sample Slope ¹	42.5°	28°	25°	21°	44°
Lateral Resolution	1 µm	1.8 µm	2.6 µm	4.6 µm	4 µm
Height Accuracy ²	20 nm	45 nm	150 nm	300 nm	100 nm
Suitable for Roughness	OK	OK	OK		OK

¹. Max Sample Slope on perfect mirror surface
². Min Z measurement depends on XY stage
³. NPX is not compatible with delta shift on the 100x100 mm stage

SOFTWARE	
Operating System: Windows 7, Windows 8, Windows 10	NPS software: Selection of calibrated sensors, Setup of XY stage, Light Intensity & Scanning Frequency, XYZ movement control. Profile mode: Acquisition and live display of profile, height / length measurement, level correction, multi profile, export in Hirox Maps pre defined template including: height, roughness, curvature and default, saving and loading XY coordinates, delta shift function
Recommended PC: min i5 6th Gen. min 8GB RAM	Surface mode: Acquisition and live display of profile and height information, export in Hirox Maps pre defined template Hirox Map - Mountains: processing of NPS files for advanced measurement including line and area roughness, volume, shape removal, tolerances with pass/fail display, batch processing, export in STL and other 3D formats, and much more

Contact

JYFEL CORPORATION SARL
 300 RN 6 - Le Bois des Côtes, Bât A
 F-69760 Limonest - FRANCE
 Tel: +33 4 26 25 03 40
 info@hirox-europe.com

Emilien Leonhardt
 European Sales Manager
 emilien@hirox-europe.com
 Tel: +49 172 44 19 555

Distributor